

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2004/0223054 A1	11-2004	Rotholtz, Ben Aaron	348/143
	В	US-2004/0061781 A1	04-2004	Fennell et al.	348/169
	C	US-2003/0197612 A1	10-2003	Tanaka et al.	340/572.1
	٥	US-6,985,172 B1	01-2006	Rigney et al.	348/149
	Ε	US-6,829,391 B2	12-2004	Comaniciu et al.	382/243
	F	US-6,774,905 B2	08-2004	Elfving et al.	345/581
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			•

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	٧	
	w	
	×	

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Applicant(s)/Patent Under Application/Control No. Reexamination 10/612,781 MONACHINO ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Sheela C. Chawan 2624 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-2004/0240542 A1 12-2004 Yeredor et al. 375/240.01 Α US-2004/0177053 A1 09-2004 Donoho et al. 706/047 В C US-2004/0061781 A1 04-2004 Fennell et al. 348/169 05-2004 348/042 D US-2004/0085440 A1 Fennell et al. 348/143 US-2004/0223054 A1 11-2004 Rotholtz, Ben Aaron Ε US-4,839,631 06-1989 Tsuji, Shintaro 340/541 F US-G USн US-USκ US-US-US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Name Classification Country Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ν W

"A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

X